## Notice of References Cited Application/Control No. 10/790,293 Examiner Wilson Lee Applicant(s)/Patent Under Reexamination MCGRATH Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,841,941	01-2005	Kim et al. ,	315/86
*	В	US-6,793,366	09-2004	Chun, James K.	362/184
*	C	US-6,388,390	05-2002	Rachwal, Erwin J.	315/200R
*	D	US-5,894,200	04-1999	Goodale et al.	315/360
	E	US-			
	F	US-			
	G	US-		,	
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			-
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## **FOREIGN PATENT DOCUMENTS**

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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